

Coexistence of diffusive resistance and ballistic persistent current in disordered metallic rings with rough edges: Possible origin of puzzling experimental values

J. Feilhauer and M. Moško*

Institute of Electrical Engineering, Slovak Academy of Sciences, 841 04 Bratislava, Slovakia

(Received 28 March 2012; revised manuscript received 29 August 2013; published 19 September 2013)

Typical persistent current (I_{typ}) in a mesoscopic normal metal ring with disorder due to rough edges and random grain boundaries is calculated by use of a scattering matrix method. In addition, resistance of a corresponding metallic wire is obtained from the Landauer formula and the electron mean free path (l) is determined. If disorder is due to the rough edges, a ballistic persistent current $I_{\text{typ}} \simeq ev_F/L$ is found to coexist with the diffusive resistance ($\propto L/l$), where v_F is the Fermi velocity and $L \gg l$ is the ring length. This ballistic current is due to a single electron that moves almost in parallel with the rough edges and thus hits them rarely (it is shown that this parallel motion exists in the ring geometry due to the Hartree-Fock interaction). Our finding agrees with a puzzling experimental result $I_{\text{typ}} \simeq ev_F/L$, reported by Chandrasekhar *et al.* [*Phys. Rev. Lett.* **67**, 3578 (1991)] for metallic rings of length $L \simeq 100l$. If disorder is due to the grain boundaries, our data reproduce the theoretical result $I_{\text{typ}} \simeq (ev_F/L)(l/L)$ that holds for the white-noise-like disorder and has been observed in recent experiments. Thus, result $I_{\text{typ}} \simeq ev_F/L$ in a disordered metallic ring of length $L \gg l$ is as normal as result $I_{\text{typ}} \simeq (ev_F/L)(l/L)$. Which result is observed depends on the nature of disorder. Experiments that would determine I_{typ} and l in correlation with the nature of disorder can be instructive.

DOI: 10.1103/PhysRevB.88.125424

PACS number(s): 73.23.Ra, 73.23.Ad, 31.70.-f, 73.23.-b

I. INTRODUCTION

It is known that a conducting ring pierced by magnetic flux can support persistent electron current.¹ Persistent currents exist in superconducting rings,² in mesoscopic resistive metal rings,^{3,5-8} in ballistic metallic rings⁹, and in nanorings made of band insulators.¹⁰

At zero temperature, the mesoscopic resistive metal ring pierced by magnetic flux Φ supports the persistent current $I = \sum_{\forall E_j \leq E_F} I_j$, where $I_j(\Phi) = -dE_j(\Phi)/d\Phi$ is the current carried by the electron with eigenenergy $E_j(\Phi)$ and E_F is the Fermi level.^{3,4,9} Function $I(\Phi)$ is periodic with period $\Phi_0 \equiv h/e$, which is an experimental signature of the persistent current.^{4,9} If the ring is clean and possesses one conducting channel, the sum $\sum I_j$ changes its sign whenever a new occupied state j is added. Due to the sign cancellation, mainly the electron at the Fermi level contributes to the sum, and the amplitude of the current is $I_0 = ev_F/L$,¹¹ where v_F is the Fermi velocity and L the ring circumference. If the ring is disordered, the size and sign of the current fluctuate from sample to sample and a typical current *per* one ring is $I_{\text{typ}} = \langle I^2 \rangle^{1/2}$, where $\langle \dots \rangle$ means ensemble average.

The number of the conducting channels (N_c) in the disordered metallic rings is usually large ($N_c \gg 1$) and the rings obey the diffusive limit, $l \ll L \ll \xi$, where l is the electron mean free path and $\xi \simeq N_c l$ is the localization length. To estimate I_{typ} , assume again that mainly the electron at the Fermi level contributes to the sum $\sum I_j$. Since $L \gg l$, the electron is expected to move around the ring by diffusion. Its transit time is $\tau_D = L^2/D$, where $D = v_F l/d$ is the diffusion coefficient and d is the sample dimensionality. So $I_{\text{typ}} \simeq e/\tau_D = (1/d)(ev_F/L)(l/L)$. A similar result follows from the Green function theory^{12,13} which assumes the noninteracting electrons and emulates disorder by a random potential $V(\mathbf{r})$ obeying the white-noise condition $\langle V(\mathbf{r})V(\mathbf{r}') \rangle \propto \delta(\mathbf{r} - \mathbf{r}')$. The theory^{12,13} gives

$$I_{\text{typ}}^{\text{theor}} = 2 \times (1.6/d)(ev_F/L)(l/L), \quad l \ll L \ll \xi, \quad (1)$$

where the factor of 2 is due to the electron spin, $d = 1, 2$, or 3, and the origin of the factor of 1.6 is explained in Ref. 14.

The first observation of the persistent current in a single metallic ring was reported⁵ for three Au rings of size $L \sim 100l$. The measured currents showed the desired flux-periodicity Φ_0 , but they were 10 to 100 times larger than result (1); they ranged from $\sim 0.1ev_F/L$ to $\sim ev_F/L$. This huge discrepancy has not been explained yet.^{15,16} Other Au rings showed⁶ the currents slightly larger than the result (1) and recent experiments^{7,8} confirmed the result (1) well.

Why did the similar measurements of diffusive Au rings^{5,7} show quite different results, $I_{\text{typ}} \simeq ev_F/L$ and $I_{\text{typ}} \simeq (ev_F/L)(l/L)$? A puzzle⁵ is why a multichannel disordered ring of length $L \gg l$ carries the current ev_F/L , typical for a one-channel ballistic ring. These questions are known as unresolved problems of mesoscopic physics.^{8,15,16}

This paper answers both questions theoretically. It is known¹⁶ that there is disorder due to polycrystalline grains and rough edges even in a pure Au ring. Using a single-particle scattering-matrix method,^{14,17} we calculate the typical persistent currents in the Au rings with grains and rough edges *without the white-noise approximation*. Another key point of our single-particle approach is that our description of the single-electron states in the ring captures an essential effect of the Hartree-Fock interaction, the cancellation of the centrifugal force by an opposite oriented Hartree-Fock field.

Our findings can be summarized as follows. If the disorder is due to the polycrystalline grains, our results agree with the white-noise-related formula (1) and experiments.^{7,8} However, if the disorder is due to the rough edges, we find the ballistic-like result $I_{\text{typ}} \simeq ev_F/L$ albeit the resistance is diffusive ($\propto L/l$) and $L \gg l$, like in the experiment.⁵ This ballistic current is due to a single electron that moves (almost) in parallel with the rough edges and thus hits them rarely. We show that this parallel motion exists in the ring geometry due to the Hartree-Fock interaction. Our major message reads as follows: The result $I_{\text{typ}} \simeq ev_F/L$ in a metal ring of length

$L \gg l$ is as normal as result $I_{\text{typ}} \simeq (ev_F/L)(l/L)$. Which result is observed depends on the nature of the disorder.

We note that we focus us on the typical current rather than on the mean current $\langle I \rangle$. The sign and amplitude of the mean current measured in the experiment by Levy *et al.*⁴ is another puzzling problem in the field. This problem has been addressed in Reference 18 within the interacting electron model. On the other hand, Reference 18 did not study the typical current. It is tempting to think that the typical current is not affected by electron-electron interaction; at least, experiments^{7,8} confirm result $I_{\text{typ}} \simeq (ev_F/L)(l/L)$ which has been derived^{12,13} for noninteracting electrons. We are thus motivated to study the typical current within a single-particle model. However, our single-particle model is not a truly noninteracting model because it captures a key effect of the Hartree-Fock interaction.

Our paper is organized as follows. In Sec. II, resistance of wires with rough edges and wires with grains is calculated by means of the scattering-matrix approach.^{14,17,19-21} In Sec. III we focus us on the single-particle states in clean metal rings. We demonstrate the key role of the Hartree-Fock interaction and we provide a simple intuitive argument about the existence of ballistic current $I_{\text{typ}} \simeq ev_F/L$ in rings with rough edges. Microscopic calculations of persistent currents are presented in Sec. IV. Finally, in Sec. V a summary of our work is given with a few concluding remarks.

II. RESISTANCE OF WIRES WITH GRAIN BOUNDARIES AND WIRES WITH ROUGH EDGES

For simplicity, we study two-dimensional (2D) rings and discuss the 3D effects briefly at the end of the paper. Experimentally,⁴⁻⁹ persistent currents in rings were studied together with the resistance of the codeposited wires in order to determine the mean free path l . In this section we study the wire resistance and mean free path. Sections II A and II B describe our transport model and our results, respectively. Of special importance is Sec. II C. It shows that our edge-roughness model gives the transport results which are universal, independent of the choice of the roughness model.

A. Transport model

We consider a stripe-shaped 2D wire (Fig. 1) described by Hamiltonian^{14,17}

$$H = -\frac{\hbar^2}{2m^*} \left(\frac{\partial^2}{\partial x^2} + \frac{\partial^2}{\partial y^2} \right) + U(x, y) + V(x, y), \quad (2)$$

where m^* is the electron effective mass, U is the grain boundary potential, and V is the potential due to the wire edges. To simulate the electron transport in wires with grain

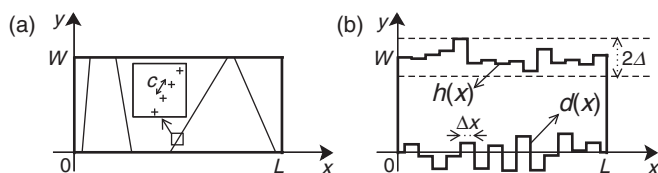


FIG. 1. Our models of disordered wires: (a) wire with grain boundaries and (b) wire with rough edges. The meaning of all symbols used in the figure is described in the main text.

boundaries, we will rely on the scattering matrix approach developed in the works.^{17,19,20} Similarly, to simulate the electron transport in wires with rough edges, we will rely on the scattering matrix approach described in the works.^{14,21} Here we review both approaches briefly by means of Fig. 1.

Let $d(x)$ and $h(x)$ be the y coordinates of the edges. Then

$$V(x, y) = \begin{cases} 0, & d(x) < y < h(x) \\ \infty, & \text{elsewhere} \end{cases}. \quad (3)$$

For smooth edges one has $d(x) = 0$ and $h(x) = W$, while in the case of the rough edges $d(x)$ and $h(x)$ fluctuate randomly in the intervals $\langle -\Delta, \Delta \rangle$ and $\langle W - \Delta, W + \Delta \rangle$, respectively. It can be shown¹⁴ that the rms of such random fluctuations (δ) is simply $\delta = \Delta/\sqrt{3}$. The fluctuations are assumed to appear along the edges abruptly with a constant step Δx which plays (within this model) the role of the roughness correlation length.¹⁴ The parameters of our roughness model are thus δ and Δx . The grain boundaries are modeled as a randomly oriented mutually nonintersecting lines, where the angle between the line and x axis is random.¹⁷ Each line consists of equidistant repulsive dots (depicted by the plus signs) with potentials $\gamma \delta(x - x_i) \delta(y - y_i)$, where (x_i, y_i) is the position of the i -th dot. Thus $U(x, y) = \sum_{vi} \gamma \delta(x - x_i) \delta(y - y_i)$. If the interdot distance c approaches zero and the ratio γ/c is fixed, a grain boundary scatters electrons as a structureless line-shaped barrier independent of the choice of c . If a 2D electron impinges on such a barrier perpendicularly with Fermi wave vector k_F , it is reflected with probability¹⁷

$$R_G = (\bar{\gamma}/c)^2 / [k_F^2 + (\bar{\gamma}/c)^2], \quad (4)$$

where $\bar{\gamma} = m^* \gamma / \hbar^2$. The parameters of our grain boundary model are the reflection probability R_G (typically²² $R_G \sim 0.1 - 0.8$) and the mean interboundary distance d_G .

We connect the wire to two ideal leads—clean long wires of width W . The spectrum of the electron wave functions $\psi(x, y)$ and electron energies E in the leads is given by

$$\psi(x, y) = e^{ikx} \chi_n(y), \quad n = 1, 2, \dots, \infty, \quad (5)$$

and

$$E = \epsilon_n + \frac{\hbar^2}{2m^*} k^2, \quad \epsilon_n \equiv \frac{\hbar^2 \pi^2}{2m^* W^2} n^2, \quad (6)$$

where k is the electron wave vector in the x direction, ϵ_n is the eigenenergy of motion in the y direction, and

$$\chi_n(y) = \begin{cases} \sqrt{\frac{2}{W}} \sin\left(\frac{\pi n y}{W}\right), & 0 < y < W \\ 0, & \text{elsewhere} \end{cases} \quad (7)$$

is the wave function in direction y . Thus, in the leads we have for the electron energy E a general wave function,^{14,17,23}

$$\begin{aligned} \psi(x, y) &= \sum_{n=1}^N [A_n^+(x) + A_n^-(x)] \sin\left(\frac{n\pi y}{W}\right), \quad x \leq 0 \\ \psi(x, y) &= \sum_{n=1}^N [B_n^+(x) + B_n^-(x)] \sin\left(\frac{n\pi y}{W}\right), \quad x \geq L \end{aligned} \quad (8)$$

where N is the considered number of channels (ideally $N = \infty$), $A_n^\pm(x) \equiv a_n^\pm e^{\pm ik_n x}$, $B_n^\pm(x) \equiv b_n^\pm e^{\pm ik_n x}$, and $k_n(E)$ is the wave vector given by equation $\frac{\hbar^2 k^2}{2m^*} + \frac{\hbar^2 \pi^2 n^2}{2m^* W^2} = E$.

Vectors $A^\pm(0)$ and $B^\pm(L)$ with components $A_{n=1,\dots,N}^\pm(0)$ and $B_{n=1,\dots,N}^\pm(L)$ obey the matrix equation^{14,17,19–21,23}

$$\begin{pmatrix} A^-(0) \\ B^+(L) \end{pmatrix} = \begin{bmatrix} r & t' \\ t & r' \end{bmatrix} \begin{pmatrix} A^+(0) \\ B^-(L) \end{pmatrix}, \quad S \equiv \begin{bmatrix} r & t' \\ t & r' \end{bmatrix}, \quad (9)$$

where S is the scattering matrix.²³ Its elements $t(E)$, $r(E)$, $t'(E)$, and $r'(E)$ are matrices with dimensions $N \times N$. Matrices t and t' are the transmission amplitudes of the waves A^+ and B^- , respectively, and matrices r and r' are the corresponding reflection amplitudes. In particular, the matrix element $t_{mn}(E)$ is the transmission amplitude from channel n in the left lead into the channel m in the right lead. We evaluate $S(E)$ for disorder in Fig. 1 by methods of Refs. 14 and 17.

At zero temperature, the wire conductance g (in units $2e^2/h$) is given by the Landauer formula $g = \sum_{n=1}^{N_c} T_n$, where

$$T_n(E_F) = \sum_{m=1}^{N_c} |t_{mn}(E_F)|^2 \frac{k_m(E_F)}{k_n(E_F)} \quad (10)$$

is the transmission probability of channel n . We evaluate t_{mn} for a large statistical ensemble of samples^{14,17} and obtain the mean transmission $\langle T_n \rangle$ and mean resistance $\langle \rho \rangle = \langle 1/g \rangle$.

B. Transport results

Our results are shown in Fig. 2. Note that the wires with grain boundaries exhibit the features typical of the white-noise-like disorder. First, $\langle \rho \rangle$ follows the usual diffusive dependence (the full line in the top left panel) in the form

$$\langle \rho \rangle = 1/N_c + (2/k_F l)(L/W), \quad (11)$$

where $1/N_c$ is the fundamental contact resistance and the mean free path l is a fitting parameter. Second, all $\langle T_n \rangle$ are equivalent in the sense that $\langle T_n \rangle \propto 1/L$ for all n .²⁴

The wires with rough edges exhibit a fundamentally different behavior. Specifically, the data for $\langle \rho \rangle$ follow the diffusive dependence (the full line in the top right panel) in the form

$$\langle \rho \rangle = 1/N_c^{\text{eff}} + (2/k_F l)(L/W), \quad (12)$$

where $1/N_c^{\text{eff}}$ is the effective contact resistance due to the N_c^{eff} open channels and both l and N_c^{eff} are the fitting parameters. The obtained values of N_c^{eff} are universal ($\simeq 6 \ll N_c$) for large N_c and small Δx (see the discussion below). The existence of the N_c^{eff} open channels reflect also the transmissions in the right panel of Fig. 2(b). Specifically, channel $n = 1$ is almost ballistic ($\langle T_1 \rangle \simeq 1$) even for $L = 0.2\xi \simeq 100l$ and a few channels with low n show $\langle T_n \rangle \sim 0.1$. Unlike the open channels, for all other channels one sees that $\langle T_n \rangle$ decays with L rapidly; these channels are in the diffusive regime or even in the localization regime.^{14,25}

Figure 3 shows in detail how l and N_c^{eff} in the wires with rough edges depend on the roughness correlation length Δx . Indeed, the N_c^{eff} versus Δx dependence shows that N_c^{eff} is a universal (N_c -independent) number of the order of 10 for small-enough Δx and large-enough N_c . The universal N_c^{eff} has been discovered in Ref. 14, and here it is demonstrated for N_c as large as 347. Further, the l versus Δx dependence shows clearly that the minimum mean free path due to the edge roughness scattering is always a few times larger than the wire

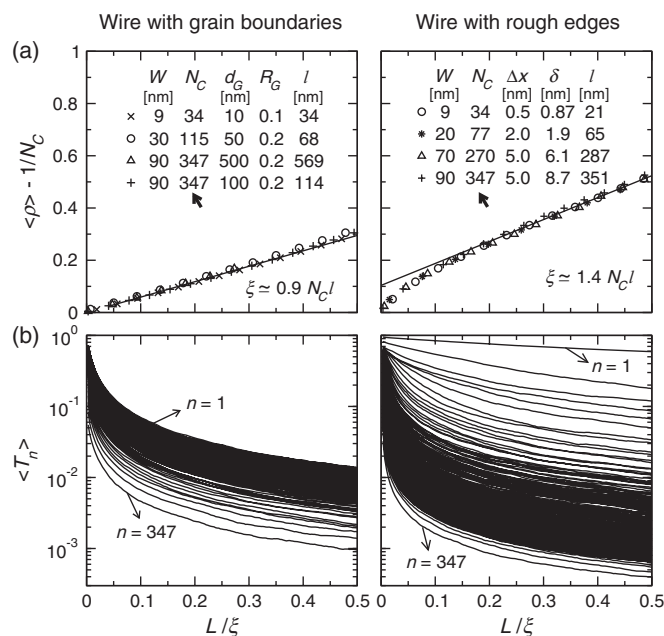


FIG. 2. Transport in disordered Au wires. Parameters of Au are $m^* = 9.1 \times 10^{-31}$ kg and $E_F = 5.6$ eV, other parameters are listed. Not to affect the results, in our calculations N is usually kept larger than N_c . (a) The mean resistance $\langle \rho \rangle$ versus L . Note that $\langle \rho \rangle$ is reduced by resistance $1/N_c$ and L scaled by ξ . The localization length ξ is obtained^{14,17} from numerical data for $\langle \ln g \rangle$ by using the fit $\langle \ln g \rangle = -L/\xi$ at $L \gg \xi$. The full lines show the linear fit of the diffusive regime (see text) from which we obtain the mean free path l (the results for l are listed in the figure). In the right panel one should see four slightly different full lines for different N_c ; we show only one of them for simplicity. (b) $\langle T_n \rangle$ versus L/ξ for parameters indicated by bold arrows. For $n = 1, 2, \dots, N_c$ the resulting curves are ordered decreasingly.

width W . This means that the edge roughness alone cannot explain the experimental^{5,7} observation $l \lesssim W$. We will return to this point later on.

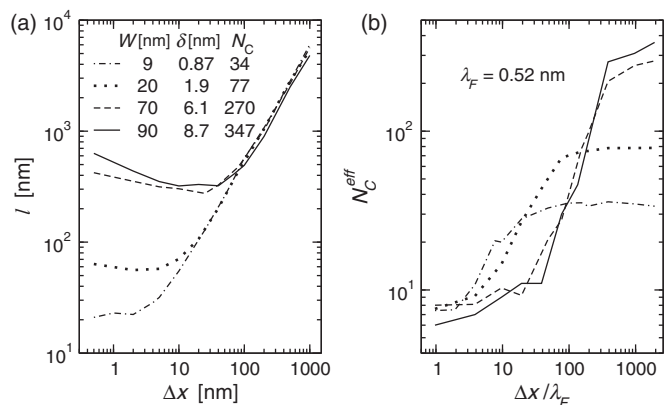


FIG. 3. (a) The mean free path l and (b) effective number of the open channels N_c^{eff} in the wire with rough edges, both plotted in dependence on the roughness correlation length Δx for the parameters as indicated. These data were extracted from the numerical data for $\langle \rho \rangle$ versus L by means of the fit $\langle \rho \rangle = 1/N_c^{\text{eff}} + (2/k_F l)(L/W)$, as it is explained in the text and in Fig. 2(a). For simplicity, ratio δ/W is kept nearly the same ($\sim 1/10$) for each set of δ and W .

C. Universality of the step-shaped-roughness model

Before we start to discuss the rings with rough edges (next sections), we want to make an important remark. In this paper, all our transport results for the wires/rings with rough edges are obtained for the step-shaped-roughness model in Fig. 1(b). We wish to point out that all these results would remain the same also for models with a smoothly varying roughness. Any smoothly varying roughness can be modeled by means of the step-shaped roughness in Fig. 1(b) if the latter is applied as a discretization scheme with very small and very dense steps. Using this approach, all calculations presented in this paper can be repeated in principle for any roughness model. We show below that the obtained transport results would agree with the results presented in this paper if they are compared at the same value of L/ξ .

It is known for the impurity disorder^{26,27} that a statistical ensemble of the macroscopically identical mesoscopic conductors with a microscopically different configuration of impurities exhibits the conductance distribution which is the same (for a given value of L/ξ) for any choice of the impurity disorder model. The weaker the disorder the better the accord of the conductance distributions for various models.

A similar universality (the independence on the specific model of disorder) seems to exist also when disorder is due to the rough edges. The conductance calculations in Ref. 25, performed for the same step-shaped-roughness model as our model in Fig. 1(b), give a quite similar results as the conductance calculations in paper,²⁸ performed for the smoothly varying roughness with Gaussian-correlation function. Here we demonstrate this universality by means of a direct comparison. We calculate the conductance for the smoothly varying roughness with Gaussian correlation (model of Ref. 28) and compare it with the conductance obtained for the step-shaped-roughness model in Fig. 1(b).

In Fig. 4 we show a typical output of our comparative study for two Au wires with the same number of the conducting channels ($N_c = 34$), so one can compare directly the individual channel transmission. It can be seen that the individual transmissions for both roughness models are in a good agreement. This illustrates the above-mentioned universality; note that the individual transmissions for both roughness models coincide albeit the values of the roughness rms and roughness correlation length in considered roughness models are (intentionally) not the same.

The universality exists also within the chosen roughness model. Specifically, all results of this paper and paper,¹⁴ obtained for the step-shaped roughness, are the same for any choice of δ and Δx if they are plotted in dependence on L/ξ .

Finally, the main result of this paper [Fig. 10(b) in Sec. IV] is that the ring with rough edges supports the ballistic persistent current $I_{\text{typ}} \simeq ev_F/L$ in spite of $L \gg l$. This results is universal simply due to its insensitivity to the edge roughness.

III. SINGLE-ELECTRON STATES IN CLEAN RINGS: EFFECT OF HARTREE-FOCK INTERACTION

In this section we study the single-electron states in clean metal rings. In Sec. III A we calculate the exact

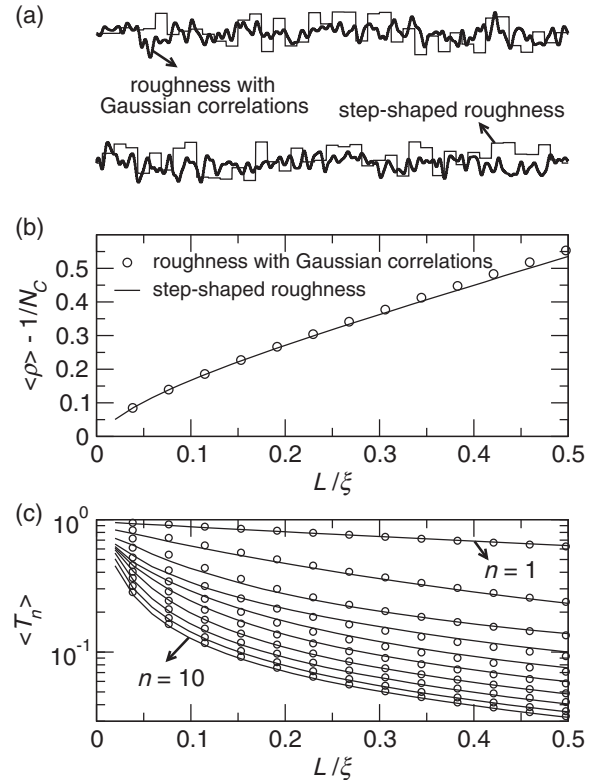


FIG. 4. (a) The top view on the 2D wire with the rough edges generated numerically for two different roughness models. In this numerical example the Au wire of width $W = 9$ nm is considered, which implies that the number of the conducting channels (N_c) is 34. For the step-shaped roughness we use the rms roughness amplitude $\delta = 0.87$ nm and roughness-correlation length $\Delta x = 0.5$ nm. For the roughness with the Gaussian correlation function we choose the rms roughness amplitude of 0.5 nm and the roughness-correlation length of 1.2 nm. In the former case we obtain the mean free path $l = 21$ nm and localization length $\xi \simeq 1.4N_c l$, and in the latter case we find $l = 20.8$ nm and $\xi \simeq 1.49N_c l$. (b) The mean resistance $\langle \rho \rangle$ versus L/ξ ; a comparison for the roughness models specified above. (c) The same comparative study as in (b), but for the channel transmissions $\langle T_n \rangle$; for clarity only the data for the first 10 conducting channels are presented.

non-interacting-electron states. We point out that the ring geometry produces the centrifugal force which pushes the noninteracting states towards the outer ring edge and makes them differ fundamentally from the states in the stripe geometry. In Secs. III B, III C, and III D we consider the Hartree-Fock interaction and we find that the non-interacting-electron ring model fails. In particular, the Hartree-Fock interaction eliminates the centrifugal force and ensures that the true single-electron states in the ring are in fact similar to those ones in the stripe.

This similarity has a serious implication. We have seen in Sec. II that the stripe with rough edges possesses a ballistic channel (channel $n = 1$) even if $L \gg l$. The same has to hold for the corresponding ring. The ring with rough edges should therefore support ballistic persistent current $I_{\text{typ}} \simeq ev_F/L$ for $L \gg l$. This effect will be studied in Sec. IV.

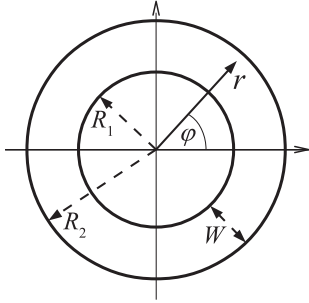


FIG. 5. The 2D ring with the inner radius R_1 and outer radius R_2 . The mean radius is $R = (R_2 + R_1)/2$, and the ring width $W = R_2 - R_1$. The data in the next two figures are calculated for $R_1 = 6.64$ nm and $R_2 = 15.64$ nm (the ring width $W = 9$ nm and the ring length $L = 2\pi R = 70$ nm) and for m^* equal to the free electron mass.

A. Clean ring with noninteracting electrons

Consider the 2D ring (Fig. 5) in the form of the annulus with the inner radius R_1 and outer radius R_2 . The noninteracting electrons in the ring without magnetic flux are described by the Schrodinger equation

$$H_0\psi(r, \varphi) = E\psi(r, \varphi), \quad (13)$$

where ψ is the wave function, E is the energy, and

$$H_0 = -\frac{\hbar^2}{2m^*} \left(\frac{\partial^2}{\partial r^2} + \frac{1}{r} \frac{\partial}{\partial r} + \frac{1}{r^2} \frac{\partial^2}{\partial \varphi^2} \right) + V(r). \quad (14)$$

Here r and φ are the polar electron coordinates (Fig. 5), and $V(r)$ is the confining potential

$$V(r) = \begin{cases} 0, & R_1 < r < R_2 \\ \infty, & \text{elsewhere} \end{cases}. \quad (15)$$

If one sets into Eq. (13) the wave function in the form

$$\psi(r, \varphi) = \frac{1}{\sqrt{L}} e^{im\varphi} \xi(r), \quad m = 0, \pm 1, \pm 2, \dots, \quad (16)$$

where $\xi(r)$ is the radial wave function and m is the angular quantum number, one obtains the radial Schrodinger equation

$$\left[-\frac{\hbar^2}{2m^*} \left(\frac{\partial^2}{\partial r^2} + \frac{1}{r} \frac{\partial}{\partial r} - \frac{m^2}{r^2} \right) + V(r) \right] \xi(r) = E\xi(r). \quad (17)$$

This equation determines the spectrum of energies $E_{n,m}$ and wave functions $\xi_{n,m}(r)$, where $n = 1, 2, \dots$. We obtain $E_{n,m}$ and $\xi_{n,m}(r)$ exactly by solving Eq. (17) numerically.

Magnetic flux can be introduced roughly by applying the substitution $m \rightarrow m + \Phi/\Phi_0$ in the Hamiltonian of Eq. (17), where Φ is the magnetic flux through the area πR^2 . If we do so, the wave functions $\xi_{n,m}(r)$ and $\xi_{n,-m}(r)$ are no longer degenerate. However, we find that the difference between them is small and we therefore discuss only $\xi_{n,m}(r)$ calculated for $\Phi = 0$.

Figure 6 shows the wave functions $\xi_{n=1,m}(r)$ calculated for the ring in Fig. 5. They are compared with wave function $\chi_{n=1}(r) = \sqrt{2/W} \sin[\frac{\pi}{W}(r - R_1)]$ which holds for the stripe geometry [Eq. (17) describes the stripe geometry if the term $\frac{1}{r} \frac{\partial}{\partial r}$ is skipped and the term $-\frac{m^2}{r^2}$ is replaced by $-\frac{m^2}{R^2}$]. The difference between the electron states in the ring and electron states in the stripe is clearly visible: In the ring the function $\xi_{n=1,m}(r)$ is shifted towards the outer ring edge by the

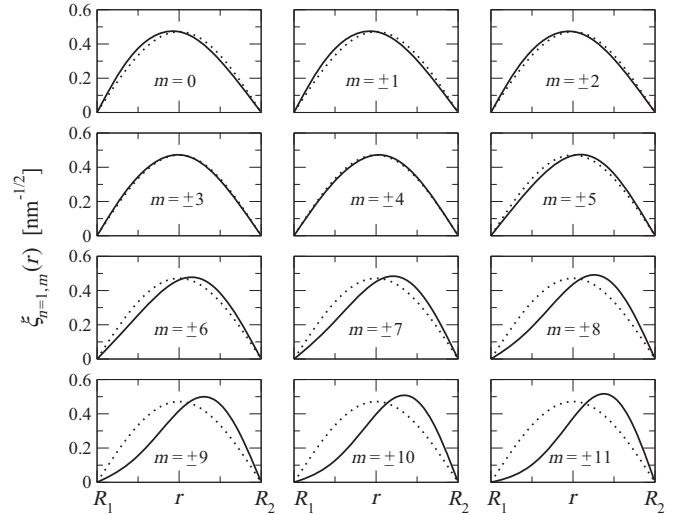


FIG. 6. The full lines show the exact wave functions $\xi_{n=1,m}(r)$ of the noninteracting electrons in the ring geometry (Fig. 5). These wave functions are normalized as $(2\pi/L) \int_{R_1}^{R_2} dr r |\xi_{n,m}(r)|^2 = 1$. The dotted lines show the electron wave function in the 2D stripe, $\chi_{n=1}(r) = \sqrt{2/W} \sin[\frac{\pi}{W}(r - R_1)]$.

centrifugal potential $\propto \frac{m^2}{r^2}$ and towards the inner ring edge by term $\frac{1}{r} \frac{\partial}{\partial r}$. Evidently, the shift towards the outer edge dominates for large $|m|$. This shift means that the electrons in channel $n = 1$ increasingly hit the outer ring edge.

A similar finding has been reported in works^{29,30} where the noninteracting electron states in metallic rings were analyzed in terms of the semiclassical trajectories. In the noninteracting model^{29,30} the electron wave functions are governed exclusively by the straight-line trajectories. In the annular geometry with $L \gg W$ it is clear at first glance that any straight-line trajectory has to hit the outer ring edge many times in order to make one trip around the ring. In particular, the so-called whispering gallery modes^{29,30} hit solely the outer edge, in accord with our observation that $\xi_{n=1,m}(r)$ tends to be localized at $r = R_2$. As a result, one finds³⁰ in channel $n = 1$ the mean free path $l \sim W$ when the ring edges are rough. We will see that these findings, including $l \sim W$ for $n = 1$, are artifacts of the noninteracting model: They fail in the presence of the Hartree-Fock interaction.

B. Hartree-Fock equation for clean ring

We still consider the single-electron states in the form

$$\psi_{n,m}(r, \varphi) = \frac{1}{\sqrt{L}} e^{im\varphi} \xi_{n,m}(r); \quad (18)$$

however, they are now described by the Hartree-Fock equation

$$[H_0 + H(r)]\psi_{nm}(r, \varphi) + F_{nm}(r, \varphi) = E_{nm}\psi_{nm}(r, \varphi), \quad (19)$$

where H_0 is the Hamiltonian of the noninteracting electrons [Eq. (14)], $H(r)$ is the Hartree interaction, and $F_{nm}(r, \varphi)$ is the Fock interaction. The Hartree interaction reads³¹

$$H(r) = -\frac{e}{4\pi\epsilon} \int_0^{2\pi} d\varphi \int_{R_1}^{R_2} dr' r' \frac{\rho(r')}{\sqrt{r^2 + r'^2 - 2rr' \cos \varphi}}, \quad (20)$$

where ϵ is the permittivity of the metal and³¹

$$\rho(r) = -2\frac{e}{L} \sum_n \sum_m [|\xi_{n,m}(r)|^2 - |\chi_n(r)|^2] \quad (21)$$

is the space charge density. Here we sum over all occupied states (n,m) , the factor of 2 incorporates two spin orientations, and

$$\chi_n(r) = \sqrt{2/W} \sin[n\pi(r - R_1)/W] \quad (22)$$

is the wave function in the stripe. The charge density (21) is due to the ring geometry: If we skip in Eq. (17) the term $\frac{1}{r} \frac{\partial}{\partial r}$ and replace the term $-\frac{m^2}{r^2}$ by $-\frac{m^2}{R^2}$, we obtain the stripe geometry with solution $\xi_{n,m}(r) \equiv \chi_n(r)$ and $\rho(r) = 0$. In golden rings there are many occupied channels and the term $2\frac{e}{L} \sum_n \sum_m |\chi_n(r)|^2$ in Eq. (21) is equal to the charge density of the positive ion background. Finally, the Fock interaction is operative between the electrons of like spin. It reads

$$\begin{aligned} F_{nm}(\varphi, r) &= -\frac{e^2}{4\pi\epsilon} \int_{R_1}^{R_2} dr' r' \int_0^{2\pi} d\varphi' \frac{(1/\sqrt{L})e^{im\varphi'} \xi_{nm}(r')}{\sqrt{r^2 + r'^2 - 2rr' \cos(\varphi - \varphi')}} \\ &\times \frac{1}{L} \sum_{n'} \sum_{m'} e^{im'(\varphi - \varphi')} \xi_{n'm'}(r) \xi_{n'm'}(r'), \end{aligned} \quad (23)$$

where we sum over all occupied states (n', m') . Evidently,

$$F_{nm}(\varphi, r) = \frac{1}{\sqrt{L}} e^{im\varphi} F_{nm}(r), \quad (24)$$

where $F_{nm}(r)$ is the radial part of $F_{nm}(\varphi, r)$,

$$\begin{aligned} F_{nm}(r) &= -\frac{e^2}{4\pi\epsilon} \frac{1}{L} \int_{R_1}^{R_2} dr' r' \int_0^{2\pi} d\theta \frac{e^{-im\theta} \xi_{nm}(r')}{\sqrt{r^2 + r'^2 - 2rr' \cos(\theta)}} \\ &\times \sum_{n'} \sum_{m'} e^{im'\theta} \xi_{n'm'}(r) \xi_{n'm'}(r'). \end{aligned} \quad (25)$$

If we set Eqs. (18) and (24) into Eq. (19), we obtain

$$\left[-\frac{\hbar^2}{2m^*} \left(\frac{\partial^2}{\partial r^2} + \frac{1}{r} \frac{\partial}{\partial r} - \frac{m^2}{r^2} \right) + V(r) + H(r) \right] \xi_{n,m}(r) + F_{nm}(r) = E_{n,m} \xi_{n,m}(r). \quad (26)$$

The last equation is the radial Hartree-Fock equation.

Equation (26) can be solved numerically by means of the Hartree-Fock iterations. In the first iteration step, the Hartree term [Eqs. (20) and (21)] and Fock term (25) are calculated by setting for $\xi_{nm}(r)$ the exact noninteracting ring states and Eq. (26) is solved numerically. This gives a new set of states $\xi_{nm}(r)$. In the second iteration step, the Hartree term and Fock term are calculated for $\xi_{nm}(r)$ obtained in the first iteration step and Eq. (26) is solved again. After many iterations a self-consistent solution is achieved; the wave functions $\xi_{nm}(r)$ obtained in two successive steps show a negligible difference. Since the self-consistent calculation is computationally cost, in this paper we obtain the self-consistent Hartree-Fock results only for rings with a single occupied channel. For the multichannel rings we perform either only the first Hartree-Fock iteration step or a so-called

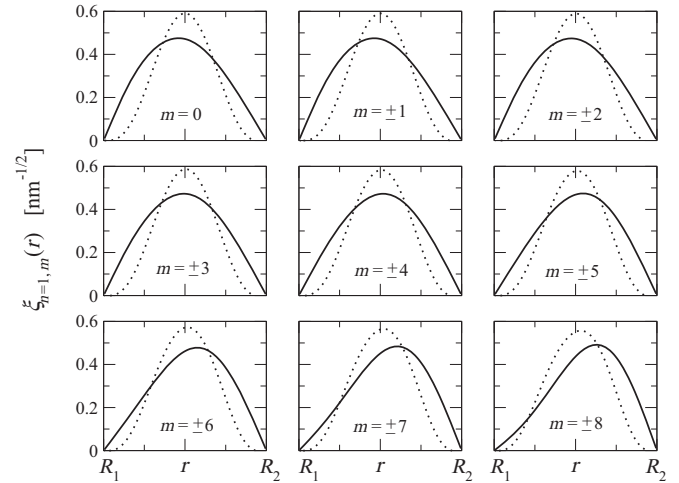


FIG. 7. Electron wave functions $\xi_{n=1,m}(r)$ for the ring in Fig. 5. The full lines show the results for the noninteracting electrons (taken from the preceding figure) and the dotted lines show the self-consistent results for the electrons that interact via the Hartree-Fock interaction. These Hartree-Fock calculations were performed for 34 electrons in the ground-state $n = 1, m = 0, \pm 1, \pm 2, \dots, \pm 8$; each (n,m) is occupied by two electrons with opposite spins. The permittivity ϵ is assumed to be equal to the permittivity of vacuum.

restricted self-consistent Hartree-Fock calculation. In spite of these restrictions, we are able to draw a few key conclusions.

C. Hartree-Fock results: Failure of the noninteracting model

Figure 7 shows again the wave functions $\xi_{n=1,m}(r)$ for the ring in Fig. 5. The full lines show the exact noninteracting ring states (taken from the preceding figure), and the dotted lines show the self-consistent Hartree-Fock results. For simplicity, in this Hartree-Fock calculation the electron number in the ring is restricted to 34 in order to occupy only channel $n = 1$. The results clearly illustrate why the noninteracting model fails. As $|m|$ increases, the noninteracting electron states (full lines) are pushed by the centrifugal force towards the outer ring edge. However, the Hartree-Fock interaction repels the electrons back. The Hartree-Fock wave functions are almost symmetric around the center of the ring cross section even for large $|m|$. Furthermore, this symmetric shape is so narrow that the wave-function tails do not reach the ring edges. This implies that the electrons in channel $n = 1$ move around the ring ballistically without collisions with the ring edges. This, however, also means that channel $n = 1$ will be ballistic even if the ring edges are rough, similarly as we have seen for the stripe geometry (the bottom right panel of Fig. 2).

Figure 7 also suggests that the true single-electron states of the clean ring, the Hartree-Fock states $\xi_{n=1,m}(r)$, can be well approximated by the non-interacting-electron wave function of the clean stripe, $\chi_{n=1}(r) = \sqrt{2/W} \sin[\frac{\pi}{W}(r - R_1)]$. Clearly, the function $\chi_{n=1}(r)$ captures the fact that the effect of the ring curvature is compensated by the Hartree-Fock field. Additionally, it is not as narrow as the Hartree-Fock states $\xi_{n=1,m}(r)$ and thus suppresses the collisions with the ring edges less effectively (one does not need to worry that the suppression is overestimated). Unlike $\chi_{n=1}(r)$, the exact noninteracting ring states $\xi_{n=1,m}(r)$ evidently fail to mimic the true single-electron

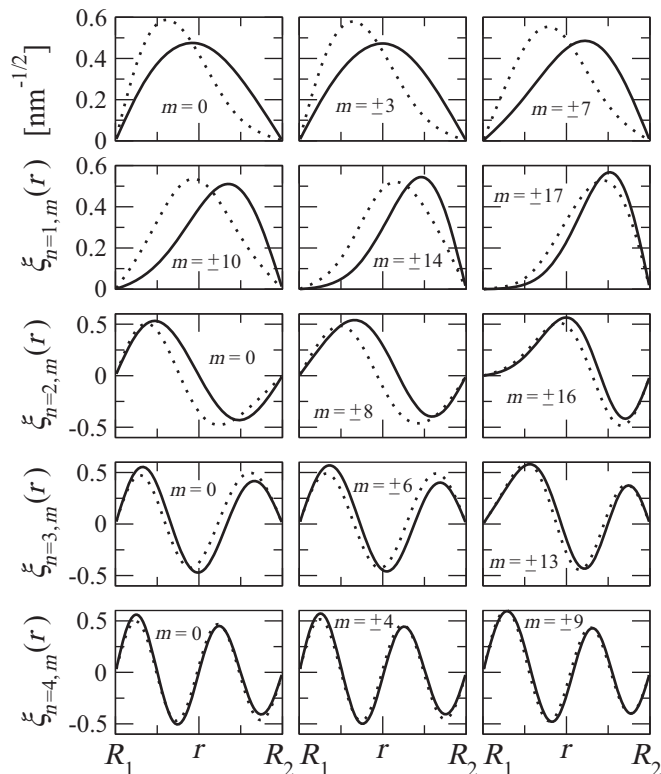


FIG. 8. Electron wave functions $\xi_{n=1,m}(r)$, $\xi_{n=2,m}(r)$, $\xi_{n=3,m}(r)$, and $\xi_{n=4,m}(r)$ for the ring in Fig. 5. The ring is filled by 228 electrons, these electrons occupy four channels, and each occupied state (n,m) contains two electrons with opposite spins. Specifically, in channel $n = 1$ there are 70 electrons in states $m = 0, \pm 1, \dots, \pm 17$, in channel $n = 2$ there are 66 electrons in states $m = 0, \pm 1, \dots, \pm 16$, channel $n = 3$ contains 54 electrons in states $m = 0, \pm 1, \dots, \pm 13$, and channel $n = 4$ contains 38 electrons in states $m = 0, \pm 1, \dots, \pm 9$. The figure shows the results for selected values of m . The full lines are the results for the noninteracting electrons [obtained by solving Eq. (17)]. The dotted lines are the Hartree-Fock results due the first Hartree-Fock iteration step.

ring states. Now we show that these findings hold also for the multichannel rings.

D. Hartree-Fock results continued: Multichannel rings

A golden 2D ring of size considered in Fig. 5 contains about 1000 electrons which occupy about 30 channels n . A self-consistent Hartree-Fock analysis of such a many-electron ring is beyond our computational possibilities. However, useful information can be obtained when only the first Hartree-Fock iteration is performed for the ring with a few occupied channels. Results of such calculation are shown in Fig. 8 for the ring with four occupied channels. The full lines show the exact noninteracting ring states and the dotted lines show the Hartree-Fock states due to the first iteration. The following features are worth noting.

As before, the exact noninteracting states are pushed towards the outer ring edge by centrifugal force, while the Hartree-Fock interaction repels the electrons in the opposite direction. In particular, most of the Hartree-Fock wave

functions in channel $n = 1$ are now shifted towards the inner edge rather than towards the outer edge. Thus, the key feature of the exact noninteracting states (the strong shift towards the outer edge by the centrifugal force) tends to diminish when the states are subjected to their own Hartree-Fock field. This is a clear sign that the exact noninteracting states fail to describe the true single-electron states in metallic rings. This also means that the modeling of the single-electron states in metallic rings by means of the straight-line paths²⁹ fails for real metal rings: The electron paths in presence of the Hartree-Fock field cannot be the straight lines.

Figure 8 also shows that the Hartree-Fock states approach the noninteracting states as the channel number n increases. Indeed, with the increase of n the centrifugal term $\propto m^2$ becomes less important because the larger the number n the smaller the occupied angular numbers m in channel n . As a result, the exact noninteracting states approach the stripe-geometry limit $\chi_n(r) = \sqrt{2/W} \sin[n \frac{\pi}{W} (r - R_1)]$ and become robust against the Hartree-Fock field.

In summary, the first Hartree-Fock iteration step in Fig. 8 shows that the exact noninteracting electron model fails to describe the true single-electron states in a clean multichannel metal ring. We have performed a similar first-iteration-step calculation also for three other rings with the same size but with a larger electron number: 6, 9, and 17 occupied channels. We have seen a clear trend: the larger the electron number, the stronger the shift of the noninteracting states towards the outer ring edge and the larger the opposite-oriented shift of the Hartree-Fock states. In other words, with increasing Fermi energy the difference between the noninteracting states and Hartree-Fock states increases and the failure of the non-interacting-ring model is more pronounced.

What are the true self-consistent Hartree-Fock states in multichannel rings? The multichannel self-consistent calculation is too extensive; a feasible task is the *restricted self-consistent* Hartree-Fock calculation. This means that we calculate the wave functions $\xi_{n,m}(r)$ self-consistently for one selected channel (say channel $n = 1$) by assuming that the electrons in channel $n = 1$ interact with the self-consistent Hartree-Fock potential due to the electrons in channel $n = 1$ and with the non-self-consistent Hartree-Fock potential due to the electrons in channels $n = 2, 3, \dots$. *Non-self-consistent* means that the Hartree-Fock potential due to channels $n = 2, 3, \dots$ is calculated by setting for $\xi_{n=2,m}(r)$, $\xi_{n=3,m}(r)$, \dots the exact noninteracting states rather than the self-consistent Hartree-Fock states.

In Fig. 9 we show again the noninteracting electron states [Fig. 9(a)] and Hartree-Fock states from the first iteration step [Fig. 9(b)], and we compare them with results of the restricted self-consistent Hartree-Fock calculation [Fig. 9(c)]. Unlike the noninteracting states in Fig. 9(a), the Hartree-Fock wave functions in Fig. 9(c) are repelled back to the center. Moreover, when compared with the wave functions in Figs. 9(a) and 9(b), the wave functions in Fig. 9(c) show a tendency to be compressed to the same symmetric form. This tendency suggests that the fully self-consistent Hartree-Fock procedure would make the wave functions in Fig. 9(c) even more symmetric and even closer to each other. Another support for this suggestion is provided by the single-channel-ring study in Fig. 7, where the (fully self-consistent) Hartree-

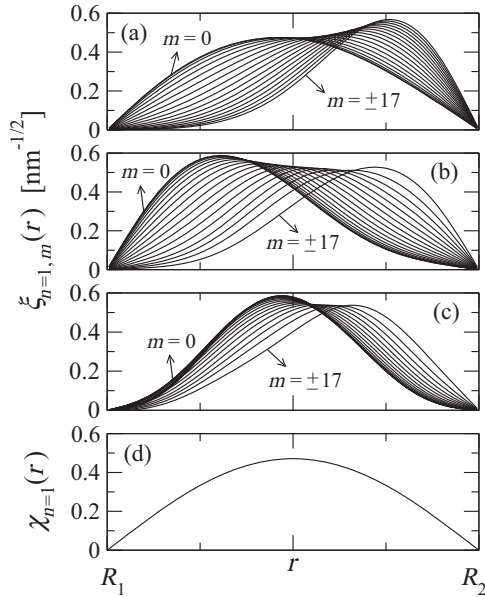


FIG. 9. Electron wave functions $\xi_{n=1,m}(r)$ with $m = 0, \pm 1, \dots, \pm 17$ in the ring with four occupied channels, considered in Fig. 8. Results from Fig. 8 are shown again in panels (a) and (b), where panel (a) shows the exact noninteracting wave functions and panel (b) shows the Hartree-Fock wave functions due to the first iteration step. Panel (c) shows the results of the *restricted self-consistent* Hartree-Fock calculation (see the main text). Panel (d) shows the stripe-geometry solution $\chi_{n=1}(r) = \sqrt{2/W} \sin[\frac{\pi}{W}(r - R_1)]$.

Fock states $\xi_{n=1,m}(r)$ are indeed almost the same and almost perfectly symmetric. So we believe that the stripe-geometry limit $\chi_{n=1}(r) = \sqrt{2/W} \sin[\frac{\pi}{W}(r - R_1)]$, proposed above for the single-channel rings, also approximates well the true single-electron states $\xi_{n=1,m}(r)$ in multichannel rings.

Note that $\chi_{n=1}(r)$ approximates quite well already the (not fully self-consistent) results in Fig. 9(c). First, it captures the tendency of the Hartree-Fock interaction to compensate the effect of the ring curvature. Second, one sees in Fig. 9(c) that the wave function tails near the edge points R_1 and R_2 are mostly suppressed much more than the tails of $\chi_{n=1}(r)$. Therefore, the Hartree-Fock states in Fig. 9(c) have to feel the edge roughness (if any) less efficiently than in state $\chi_{n=1}(r)$. Thus, approximation $\xi_{n=1,m}(r) \simeq \chi_{n=1}(r)$ certainly does not underestimate the edge roughness scattering in the ring.

Finally, approximation $\xi_{n=1,m}(r) \simeq \chi_{n=1}(r)$ can be extended to all n as $\xi_{n,m}(r) \simeq \chi_n(r)$, because the effect of the centrifugal force diminishes with increasing n (Fig. 8). In conclusion, the true single-electron states of the clean metallic ring, the self-consistent Hartree-Fock states, can be approximated by the noninteracting states of the clean metallic stripe,

$$\psi_{n,m}(r, \varphi) \simeq \frac{1}{\sqrt{L}} e^{im\varphi} \sqrt{\frac{2}{W}} \sin\left[n \frac{\pi}{W} (r - R_1)\right], \quad (27)$$

of course, with eigenenergies

$$E_{n,m} \simeq \frac{\hbar^2 \pi^2}{2m^* W^2} n^2 + \frac{\hbar^2}{2m^* R^2} m^2. \quad (28)$$

To add magnetic flux Φ , substitution $m \rightarrow (m + \Phi/\Phi_0)$ has to be used on the right-hand side of Eqs. (27) and (28). Approximation $\xi_{n,m}(r) \simeq \chi_n(r)$ captures the fact that the effect of Φ on the numerically obtained $\xi_{n,m}(r)$ is hardly visible.

We have seen in Sec. II that in the stripe with rough edges the channel $n = 1$ is ballistic for $L \gg l$. Since $\xi_{n=1,m}(r) \simeq \chi_{n=1}(r)$, channel $n = 1$ has to be ballistic also in the ring with rough edges, and such a ring should therefore support ballistic persistent current $I_{\text{typ}} \simeq ev_F/L$ even if $L \gg l$. This ballistic current is studied in the next section. In contrast to our result, the noninteracting model predicts^{29,30} for channel $n = 1$ the diffusive mean free path $l \sim W$, whenever the ring with rough edges is of size $L \gg W$. This prediction is an artifact of the noninteracting model.

IV. PERSISTENT CURRENTS IN RINGS WITH GRAIN BOUNDARIES AND ROUGH EDGES

Assume that the wires in Figs. 1(a) and 1(b) are circularly shaped in the plane of the 2D gas and the wire ends are connected. So we have a 2D ring with grain boundaries and a 2D ring with rough edges. *What are the persistent currents in such rings?* In this section we answer the question by means of simple intuitive arguments (Sec. IV A) and by means of the first-principle simulation (Sec. IV B). Simulation results for typical persistent currents are presented in Sec. IV C, and Sec. IV D presents the sample-specific currents. In Sec. IV E we simulate typical persistent currents in rings with combined disorder due to the rough edges and grain boundaries, compare them with experiment,⁵ and explain the anomalous experimental data.

A. Intuitive arguments

For rings with random grain boundaries one can safely expect the standard diffusive result $I_{\text{typ}} \simeq (ev_F/L)(l/L)$, because the corresponding metallic stripe shows the standard diffusive resistance (left panels of Fig. 2). This expectation agrees with our microscopic results shown later. We note that our grain-boundary model [Fig. 1(a)] is universal in the sense that any other grain-boundary model with random boundaries would give again the diffusive conductance and diffusive persistent current. Indeed, diffusive transport is caused by the random orientation and random positions of grain boundaries, not by microscopic details of the individual boundary.

For the rings with rough edges the situation differs markedly. We have seen in Sec. III that the electron states in clean rings and clean stripes are similar, in particular $\xi_{n=1,m}(r) \simeq \chi_{n=1}(r)$. In addition, in Sec. II we have seen that channel $n = 1$ in the stripe with rough edges possesses at $L \gg l$ the transmission $\langle T_1 \rangle \simeq 1$ [the right panel of Fig. 2(b)]. Since $\xi_{n=1,m}(r) \simeq \chi_{n=1}(r)$, channel $n = 1$ has to be ballistic also in the ring with rough edges and the persistent current in such ring can be estimated as follows. Assume roughly that $\langle T_n \rangle = 1$ for $n = 1$ and $\langle T_n \rangle \sim l/L$ for all other n . In this model, channel $n = 1$ contributes by ballistic current $I_{\text{typ}} = ev_F/L$ while the total contribution from other channels is diffusive, $I_{\text{typ}} \simeq (ev_F/L)(l/L)$, and negligible for $L \gg l$. Thus, multichannel rings with rough edges should support at $L \gg l$ the typical currents $I_{\text{typ}} \simeq ev_F/L$, expected to exist only in ballistic single-channel rings.

In terms of classical paths, the rough edges scatter all electrons except for a small part of those that move (almost) in parallel with the edges. This small part, mainly the electrons that occupy channel $n = 1$, hits the edges rarely and thus moves almost ballistically. We recall (see Sec. III) that the motion parallel with the edges exists in the ring geometry due to the Hartree-Fock interaction. It eliminates the effect of the ring geometry and establishes the relation $\xi_{n=1,m}(r) \simeq \chi_{n=1}(r)$.

B. Microscopic model

We start with the clean ring. According to Sec. III, the true single-electron states of the clean ring (the Hartree-Fock states) can be approximated by the noninteracting electron states of the clean stripe as shown in Eqs. (27) and (28). One can define variables x and y by transformation $R\varphi \rightarrow x$ and $(r - R_1) \rightarrow y$ and rewrite equations (27) and (28) as

$$\psi_{n,m}(x,y) = \frac{1}{\sqrt{L}} e^{ik_m x} \sqrt{\frac{2}{W}} \sin \left[n \frac{\pi}{W} y \right] \quad (29)$$

and

$$E_{n,m} = \frac{\hbar^2 \pi^2}{2m^* W^2} n^2 + \frac{\hbar^2}{2m^* L^2} k_m^2, \quad (30)$$

where $k_m = \frac{2\pi}{L}(m + \Phi/\Phi_0)$. If we take the Hamiltonian of the clean stripe [Hamiltonian (2) without disorder] and write Schrodinger equation $H\psi(x,y) = E\psi(x,y)$, the wave functions (29) and eigenenergies (30) are evidently its solutions. It is customary to view this approach as a quasi-1D approximation in which the *non-interacting-electron* states of the 2D ring are naively mapped on the noninteracting electron states of the straight stripe via transformation $R\varphi \rightarrow x$, $(r - R_1) \rightarrow y$. In fact, this mapping is not a quasi-1D approximation for the noninteracting 2D states. The states mapped on the noninteracting states of the stripe are the Hartree-Fock states of the ring, and this mapping is due to the fact that the Hartree-Fock interaction acts against the centrifugal force and eliminates the effect of the ring geometry. If one uses this mapping, one in fact captures the key effect of the Hartree-Fock interaction without any Hartree-Fock calculation.

In case of disordered rings, the Hartree-Fock interaction is expected to play a key role in the rings with rough edges (see the discussion in Sec. III). In this case the Hartree-Fock analysis would be even more tedious than for the clean rings. Fortunately, the mapping approach is a reasonable and viable alternative which can easily be extended to disordered rings.

We bend the disordered 2D stripe in Fig. 1 to form a 2D ring similar to the one in Fig. 5 but disordered. We describe the electron states in the ring by Hamiltonian of the constituting stripe by Hamiltonian (2). The ring is mapped on the stripe by assuming that the x coordinate in Hamiltonian (2) is the electron position along the ring circumference and y is the position along the ring radius. We can thus apply directly the scattering matrix calculation for the disordered stripe (Sec. II). Of course, now this calculation has to be supplemented by cyclic boundary conditions,¹²

$$\begin{aligned} \psi(0,y) &= \exp(-i2\pi\Phi/\Phi_0)\psi(L,y), \\ \frac{\partial\psi}{\partial x}(0,y) &= \exp(-i2\pi\Phi/\Phi_0)\frac{\partial\psi}{\partial x}(L,y), \end{aligned} \quad (31)$$

where the exponential factor is the Peierls phase. We set into Eqs. (31) the expansion (8) and rewrite them as

$$\begin{pmatrix} \mathbf{A}^-(0) \\ \mathbf{B}^+(L) \end{pmatrix} = \begin{bmatrix} 0 & Q^{-1}(\phi) \\ Q(\phi) & 0 \end{bmatrix} \begin{pmatrix} \mathbf{A}^+(0) \\ \mathbf{B}^-(L) \end{pmatrix}, \quad (32)$$

where Q is the $N \times N$ matrix with terms $Q_{\alpha\beta} = e^{i2\pi\Phi/\Phi_0}\delta_{\alpha\beta}$. The scattering matrix equation (9) has to be fulfilled together with cyclic conditions (32). This happens for discrete energies $E = E_j(\Phi)$ which we find for a given ring numerically.¹⁷

Again, it is tempting to consider the above mapping approach as a quasi-1D approximation¹² and to think about a truly-2D calculation for *noninteracting electrons* [with disorder introduced in the 2D-ring Hamiltonian (14)]. We recall that the truly-2D calculation without the Hartree-Fock interaction fails to describe the true single-electron states in clean rings and rings with rough edges. The mapping approach captures the key effect of the Hartree-Fock interaction.

Once we know the ring spectrum $E_j(\Phi)$, we calculate the sample-specific current $I = -\sum_{\forall E_j \leq E_F} dE_j/d\Phi$ and eventually the typical current $I_{\text{typ}} \equiv \langle I^2 \rangle^{1/2}$, where $\langle I^2 \rangle$ is averaged over a small energy window at E_F . Technical details of averaging are explained in Ref. 17 and also in Sec. IV D.

C. Results for typical currents: A comparison for random grain boundaries and rough edges

Figure 10 shows our main results. For the rings with grain boundaries one can see that our data for I_{typ} agree (at large L) with the diffusive result $I_{\text{typ}}^{\text{theor}} = 1.6(ev_F/L)(l/L)$. This agrees with experiments,^{7,8} illustrates the universality (the white-noise-like properties) of our random-grain-boundary model, and confirms the intuitive expectations of Sec. IV A.

For the rings with rough edges, however, our data for I_{typ} are systematically (not regarding the data fluctuations) close

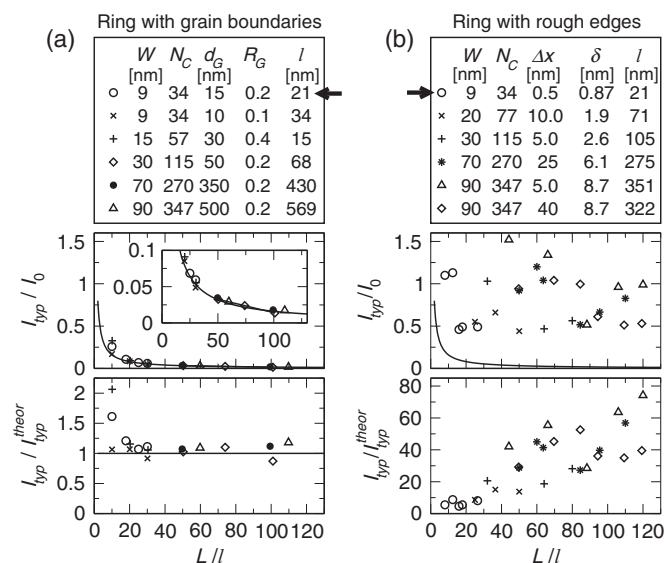


FIG. 10. Typical persistent current I_{typ} versus L/l in disordered Au ring. The ring parameters are shown, $\Phi = -0.25h/e$, l has been obtained from the wire resistivity (Fig. 2). The arrows point the parameters studied further in Fig. 12. Symbols are our data, and full lines show the formula $I_{\text{typ}}^{\text{theor}} = 1.6(ev_F/L)(l/L)$.

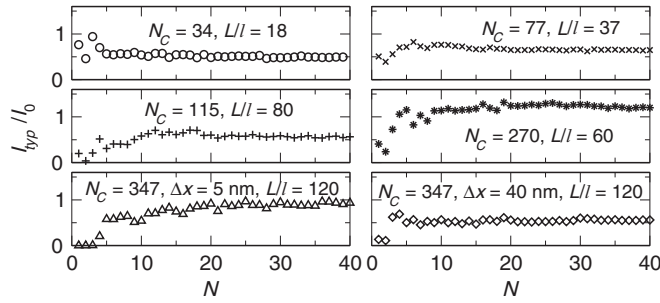


FIG. 11. Typical persistent current I_{typ} in the ring with rough edges as a function of the total number of channels (N) considered in the simulation. The same parameters and symbols are used as in Fig. 10(b), and the considered ring lengths are shown as L/l .

to the ballistic one-channel value $I_0 = ev_F/L$, albeit $L \gg l$, $N_c \gg 1$, and $\langle \rho \rangle \propto L$. All this agrees with experiment^{5,13} and this agreement is discussed in detail in Sec. IV E. In the preceding text we have arrived at the result $I_{\text{typ}} \sim ev_F/L$ intuitively by assuming that the electrons in channel $n = 1$ almost entirely avoid the scattering with rough edges and thus carry the ballistic current $\sim ev_F/L$. Now we make this intuitive argument more precise.

In Fig. 11 we show how the typical current in the ring with rough edges depends on the number of channels (N) considered in the simulation. It is (roughly) N independent for $N \gtrsim 10$, no matter how large N_c is. In other words, the currents $\sim I_0$ in rings with rough edges exist due to the open channels $n = 1, 2, \dots, N_c^{\text{eff}}$, where $N_c^{\text{eff}} \sim 10$ for any value of N_c (see also Fig. 3). Since $\langle T_1 \rangle \sim 1$, our intuitive argument invokes that the value $I_{\text{typ}} \sim I_0$ will survive also if one chooses N as small as $N = 1$. Figure 11 shows that this is not the case. For instance, in the ring with $N_c = 347$ and $L/l = 120$ the current for $N \rightarrow 1$ is quite close to zero. This is easy to understand: Once the channel $n = 1$ cannot communicate with other channels, the transmission $\langle T_1 \rangle \sim 1$ tends to be suppressed to zero by Anderson localization, present in any sufficiently long 1D disordered system. Communication with a few other channels is needed to restore $\langle T_1 \rangle \sim 1$ and to obtain $I_{\text{typ}} \sim I_0$.

D. Sample-specific currents

To provide further insight, Fig. 12 shows the sample-specific currents in two selected rings from Fig. 10 (bold arrows) and in a clean ring. Figure 12(a) shows the dependence I_j versus E_j , and Fig. 12(b) shows the total current $I = \sum_{\forall E_j \leq E_F} I_j$ versus E_F . Evidently, the ring with rough edges exhibits remarkably larger currents than the ring with grain boundaries, albeit both rings are of the same size and possess the same value of l .

Figures 12(c) and 12(d) focus on a small energy window below the Au Fermi level. One can see that I_j in the ring with rough edges exhibits sharp peaks with the sign alternating and oscillating with period $\Delta E = 2\pi\hbar v_F/L$. This period is twice the interlevel distance in the ballistic single-channel ring, which suggests that the peaks are due to the quasiballistic channel $n = 1$. [We recall that $\langle T_1 \rangle \sim 1$ also for $L/l \gg 1$, as is shown in the right panel of Fig. 2(b).] However, the

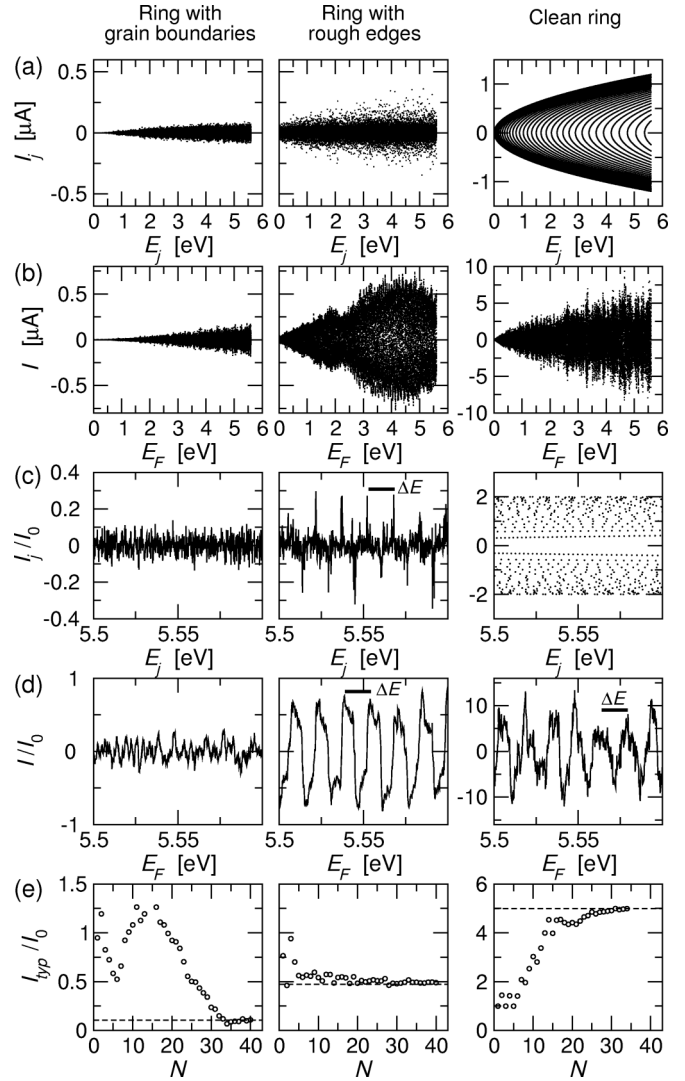


FIG. 12. Persistent currents in a ring with grain boundaries, a ring with rough edges, and a clean ring for the parameters marked by the arrows in Fig. 10, for $L = 375$ nm, and for $\Phi = -0.25h/e$. For both disordered rings, the considered parameters ensure $l(E_F) = 21$ nm at the Au Fermi level ($E_F = 5.6$ eV). Figure (a) shows the single-electron current I_j versus the eigen-energy E_j . Figure (b) shows the total current $I = \sum_{\forall E_j \leq E_F} I_j$ obtained by summing the currents in the figure (a) for E_F varied from 0 to 5.6 eV. Figures (c) and (d) show the same data as the figures (a) and (b), but for a small energy window below the Au Fermi level. The data are scaled by $I_0 = ev_F/L$, the data points are connected by full lines which serve as a guide for the eye, the bars depict the energy increment $\Delta E = 2\pi\hbar v_F/L$. Figure (e) shows the typical current $I_{\text{typ}} \equiv \langle I^2 \rangle^{1/2}$. Averaging over the energy window in figure (d) gives the values shown by dashed lines: $I_{\text{typ}}/I_0 \simeq 1.6(l/L)$ for the ring with grain boundaries, $I_{\text{typ}}/I_0 \simeq 0.5$ for the ring with rough edges, and $I_{\text{typ}}/I_0 \simeq \sqrt{N_c}$ for the clean ring.³² The circles show the data obtained by varying the number of channels, N , from $N = 1$ to $N > N_c$ (here $N_c = 34$).

height of the peaks is affected also by other channels, because, as discussed above, channel 1 cannot keep $\langle T_1 \rangle \sim 1$ without communicating with a few other channels.

In Fig. 12(d) one can see that in the ring with rough edges also the total current $I(E_F)$ oscillates with period ΔE . The

amplitudes of the total current are close to I_0 , and therefore the typical currents of size $\sim I_0$ appear in Fig. 10(b).

In fact, the data for the clean ring show $I(E_F)$ oscillating with period ΔE . However, the amplitude of I is $\sim \sqrt{N_c} 2I_0$ ³² and the amplitude of I_n is $2I_0$, where the factor of 2 is due to the spin. Evidently, the rough edges reduce I from $\sim \sqrt{N_c} 2I_0$ to $\sim I_0$, but they do not change the oscillation period set by the clean ring. Note that also the ring with grain boundaries exhibits the oscillating persistent current. These oscillations are chaotic and correlated with correlation length $\sim (l/L)\Delta E$, predicted^{12,13} for the white-noise-like disorder.

Figure 12(e) shows the typical current. The dashed lines show the values of I_{typ} obtained from the data in Fig. 12(d), and the circles show I_{typ} in dependence on N . For all three rings one sees that the circles approach with raising N the N -independent value (the large N limit) represented by the dashed line. It can be seen that a reliable estimate of I_{typ} in the ring with grain boundaries requires $N \gtrsim N_c$, while for the ring with rough edges one only needs $N \sim 10$ no matter how large N_c is. This is due to the effective number $N_c^{\text{eff}} \sim 10$, as has already been explained in the beginning of this section.

E. Combined effect of rough edges and random grains: Comparison with experiment

In experiment⁵ the persistent current $\sim I_0$ was observed in the Au ring with $L \simeq 100l$ and $W = 90$ nm. Indeed, Fig. 10(b) demonstrates $I_{\text{typ}} \sim I_0$ also for $L/l \simeq 100$ and $W = 90$ nm. The difference is that the work⁵ has reported $l \simeq W$ ($l = 70$ nm for $W = 90$ nm) while our values of l in Fig. 10(b) [see also Fig. 3(a)] are at least 2 times larger than W ; the edge roughness alone cannot produce $l \simeq W$. In reality, the edge roughness coexists with other types of disorder. Reference 5 did not specify disorder in measured samples, but Webb mentioned³³ that the grains in the rings of work⁵ were much larger than W (say, in Ref. 34, $d_G \simeq 8W$). The grains with $d_G \gg W$ are known as bamboolike grains.³⁵⁻³⁷ Of course, $d_G \gg W$ and $l \simeq W$ ⁵ means $l \ll d_G$, which suggests that the grain boundaries were not the main source of scattering in work.⁵ If the random grain boundaries (or impurities) were the main source of scattering, the measured persistent current⁵ would be $\sim (l/L)I_0$ rather than $\sim I_0$ (cf. Fig. 10 and Ref. 17). What remains is the edge roughness and it indeed explains the mysterious coexistence of the results $I_{\text{typ}} \simeq I_0$, $L/l \gg 1$, and $\langle \rho \rangle \propto L$. What happens if one adds the bamboolike grains?

Since $d_G \gg W$, we fit R_G to obtain $l \simeq W$. Figure 13 shows such a study for the same W and similar L as in Ref. 5. In Fig. 13(a) we see again the diffusive law $\langle \rho \rangle \propto L/l$ but now $l \simeq W$, like in Ref. 5. Figure 13(b) shows that the transmission through channels 1, 2, and a few more is still large (between 1 and 0.1), though not as large as in the wire with rough edges only [cf. the right panel of Fig. 2(b)]. A suppression of the transmission, caused by a combined effect of the rough edges and bamboolike grains, is visible for all 347 channels. Consequently, $l \simeq W$. Similarly, the typical currents in Figs. 13(c) and 13(d) are suppressed in comparison with the pure edge-roughness case [Fig. 10(b)], but they still grossly exceed the value $I_{\text{typ}}^{\text{theor}} = 1.6(ev_F/L)(l/L)$. Figure 13(c) presents the maximum currents, because Ref. 5 in fact reported the current amplitudes rather than I_{typ} . These

Wire/ring with rough edges and bamboolike grains ($d_G = 7.7W$)

	W [nm]	N_c	Δx [nm]	δ [nm]	d_G [nm]	R_G	α_0	l [nm]	$\xi/N_c l$
\triangle	90	347	5.0	8.7	700	0.2	0	85.2	0.95
\circ	90	347	5.0	8.7	700	0.2	$\pi/16$	97.0	0.90
\square	90	347	5.0	8.7	700	0.2	$\pi/8$	100	0.89

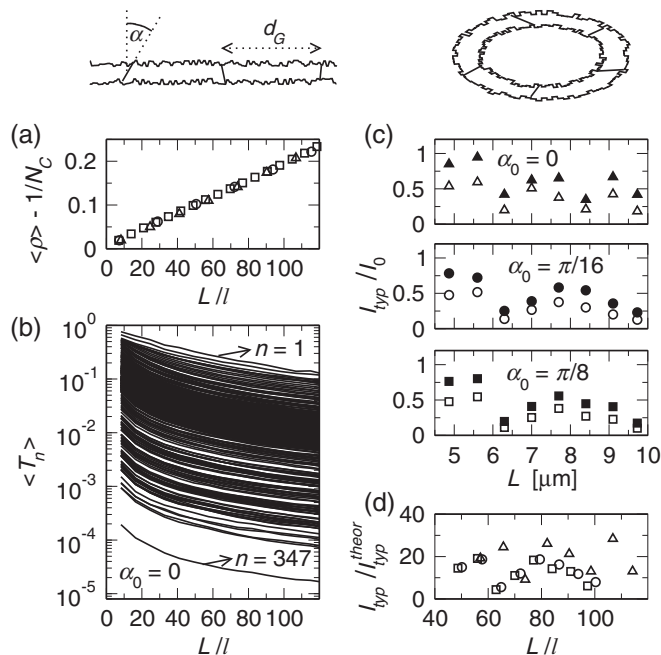


FIG. 13. Transport in Au wires and Au rings with rough edges and bamboolike grains. The angle α of the grain boundary is chosen at random from the interval $(-\alpha_0, \alpha_0)$, where α_0 is the parameter: $\alpha_0 = 0$ means the ideal bamboo shape with the boundary perpendicular to the wire.³⁵⁻³⁷ The table shows all parameters and the resulting l and ξ . (a) The mean resistance $\langle \rho \rangle$ versus L/l ; (b) the transmission $\langle T_n \rangle$ versus L/l for $\alpha_0 = 0$. Open symbols in (c) show the typical current I_{typ}/I_0 versus L for various α_0 , and the full symbols show the maximum currents. (d) The I_{typ} data from (c) normalized by $I_{\text{typ}}^{\text{theor}} = 1.6(ev_F/L)(l/L)$ and plotted in dependence on L/l .

amplitudes were between $\sim 0.1I_0$ and $\sim I_0$ and are essentially the same as our data (the full symbols).

V. SUMMARY AND CONCLUDING REMARKS

A. Summary

In our paper, persistent currents in mesoscopic normal-metal rings with disorder due to the rough edges and random grain boundaries have been calculated by means of the single-particle scattering-matrix method. In addition, the diffusive resistance of corresponding metallic wires has been obtained from the Landauer formula and the diffusive electron mean free path has been determined. Our calculations capture two crucial points. First, disorder is described microscopically; we do not rely on the approximation of the spatially homogeneous white noise. Second, our description of the single-electron states in the ring captures the key effect of the Hartree-Fock interaction, the cancellation of the centrifugal force by an opposite oriented Hartree-Fock field.

Our main results (Fig. 10) are the following. If disorder is due to the random grain boundaries, our results for the typical persistent current agree with the white-noise-related formula $I_{\text{typ}} \simeq (ev_F/L)(l/L)$ and recent experiments.^{7,8} However, if the disorder is due to the rough edges, we find the ballistic-like current $I_{\text{typ}} \simeq ev_F/L$ albeit the resistance is diffusive ($\propto L/l$) and $L \gg l$. In other words, the multichannel disordered metal ring of length $L \gg l$ supports the current $I_{\text{typ}} \simeq ev_F/L$, expected to exist only in a single-channel disorder-free ring. This finding agrees with experiment.⁵

Thus, Fig. 10 naturally explains the difference between the experiment⁵ and experiments.^{7,8} It simply suggests that disorder in samples of works^{7,8} was white-noise-like (most likely mainly due to the random grain boundaries), while disorder in samples of work⁵ was likely mainly due to the rough edges. Ideally, the ballistic persistent current is inherent to metallic rings with rough edges. However, according to our data in Fig. 13, it survives (slightly suppressed) also when the bamboo-like polycrystalline grains are added in order to emulate the polycrystallinity of the real rings.⁵

The microscopic origin of the ballistic persistent current in metallic rings with rough edges has been explained. The ballistic current is mainly due to the electrons that occupy channel $n = 1$. Classically speaking, these electrons move (almost) in parallel with the ring edges and therefore avoid the edge roughness scattering. The reason why they move in parallel with the ring edges in spite of the ring geometry is the Hartree-Fock interaction; it acts against the centrifugal force and eliminates the effect of the ring geometry. In terms of classical paths, the electron paths in presence of the Hartree-Fock field are not the straight lines; the field deflects them from the outer ring edge and the resulting electron wave function is centered between the edges almost symmetrically.

Finally, we recall that all our results are universal. The transport results obtained for the grain boundary model in Fig. 1(a) hold for any other grain boundary model in which the orientation and positions of the boundaries are random. The transport results obtained for the step-shaped-roughness model in Fig. 1(b) hold also for models with a smoothly varying roughness (Sec. II C). The universality exists also within our specific roughness model; all our results are robust against the change of parameters δ , Δx , N_c , l , and L , if they are plotted in dependence on L/ξ . Therefore, a missing information on the nature of disorder in measured samples^{5,7,8} is not crucial for our conclusions. In any case, our values of δ and Δx are close to the real ones.³⁸ In principle, we could attempt to reproduce the measured values of I_{typ} and l exactly by fitting the parameters of disorder. This should make sense if new experiments determine I_{typ} and l together with the parameters of disorder in measured samples.

B. Remark on robustness of the 2D results against 3D effects

Our results were obtained for the 2D model of Fig. 1, while the experimental samples^{5,7,8} are three-dimensional. We want to point out that the extension of our 2D study to 3D would not change our results remarkably. The effect of 3D can be estimated without an explicit calculation.

In our 2D wire [Fig. 1(b)] the roughness scattering is due to the wire edges. In real 3D wires the roughness scattering

is in general due to the wire edges (side walls) as well as due to the top and bottom surfaces. In spite of this difference the 3D sample preserves the key feature of our 2D model. Namely, the electrons in the ground 1D channel (now the channel with quantum numbers $n_y = 1$ and $n_z = 1$, where z is the vertical direction) still move almost in parallel with the sample edges and sample surfaces and therefore avoid the roughness scattering. Thus, the transmission through the ground 1D channel has to be ballistic, similarly as we have seen for the 2D wire (Fig. 2). Consequently, the 3D rings have to carry for $L/l \gg 1$ the ballistic current $I_{\text{typ}} \simeq ev_F/L$, similarly as the 2D rings in Fig. 10(b).

Further, the roughness scattering in 3D does not modify the mean free path l remarkably in comparison with 2D. Indeed, in real 3D wires the roughness amplitude (rms) of the top and bottom surfaces is usually of the order of one lattice constant (~ 0.5 nm; see e.g. the paper³⁹), which is far less than the roughness amplitude at the edges (rms ~ 5 nm–10 nm; see the experiment³⁸ and our present paper). Since the roughness-limited mean free path is proportional to the square of the rms,¹⁴ the effect of the top and bottom surfaces on the mean free path has to be two orders of magnitude weaker than the effect of the edges. It is thus very likely that the roughness scattering in the 3D wires of Ref. 5 is mainly due to the wire edges.

Finally, unlike the 2D wire in Fig. 1, the edges of the 3D wire are the side walls and the edge roughness at such side walls in general scatters the electrons also in the vertical (z) direction. In comparison with our purely 2D scattering, this may decrease the roughness-limited mean free path say by a few tens of percentage points. However, this cannot affect the ballistic-like motion in the ground 1D channel, responsible for the ballistic current $I_{\text{typ}} \simeq ev_F/L$ at $L/l \gg 1$.

C. Remark on an angle dependence of roughness scattering

In the non-interacting-electron model of the 2D ring the wave functions are dominated by the straight-line electron paths.^{29,30} To incorporate the edge roughness scattering in that model, it was assumed³⁰ that any straight-line path which hits the ring edge is reflected diffusively no matter what is the incidence angle (the angle between the path and the edge). However, a realistic probability of diffusive reflection, derived by Ziman and Soffer^{40,41} for a free wave impinging the surface with uncorrelated roughness, strongly depends on the incidence angle. It is equal to unity for perpendicular incidence but approaches zero for small incidence angles. Note that the realistic angle dependence of the edge roughness scattering is inherent to our scattering matrix method.

Indeed, the tendency to a specular reflection at small angles is manifested by the channel transmission T_n . Let us look at the right panel of Fig. 2(b) in detail. Classically, the channel number n corresponds to the angle between the classical trajectory and edge, and $n = 1$ corresponds to the smallest nonzero classical angle allowed by the quantum confinement. Consider, say, $L \simeq 0.25\xi \simeq 120l$. In case of the diffusive reflection assumed by work,³⁰ for $L/l = 120$ we should observe $T_n \sim l/L \sim 1/120$ for all n including $n = 1$. However, this is not the case; the right panel of Fig. 2(b) shows that T_n is between 1 and 0.1 for $n = 1, 2, \dots, 6$. Evidently, the

electron motion in these channels is much more ballistic than diffusive. When this realistic angle dependence is combined with the Hartree-Fock interaction, the metallic rings with rough edges support for $L \gg l$ the ballistic current $I_{\text{typ}} \simeq ev_F/L$.

D. $T = 1$ as a general feature of any diffusive wire and $T_{n=1} \simeq 1$ in the wire with rough edges: Two different things

We note that the transmission $T_{n=1} \simeq 1$ in the wire with rough edges [right panel of Fig. 2(b)] has nothing in common with the well-known bimodal distribution $1/\sqrt{(1-T)T^2}$, which exists in any diffusive conductor²⁴ and diverges for $T = 1$. Transmissions T in the bimodal distribution are the eigenvalues of the t^+t matrix²⁴, and our $T_n = \sum_{m=1}^{N_c} |t_{n,m}|^2$ are the diagonal elements of the t^+t matrix. In other words, the channels corresponding to the eigenvalues T in the distribution $1/\sqrt{(1-T)T^2}$ are the eigenstates of the t^+t matrix and the channels corresponding to our diagonal elements T_n are the plane-wave states. This difference deserves a few remarks.

The bimodal distribution $1/\sqrt{(1-T)T^2}$ as a general property of any diffusive conductor with white-noise-like disorder²⁴ coexists with the diffusive persistent current $I_{\text{typ}} \simeq (ev_F/L)(l/L)$ in the corresponding disordered ring.¹² This means that the eigenvalues $T = 1$ in the bimodal distribution do not cause any ballistic persistent current. The reason why the current is diffusive in spite of $T = 1$ is most likely that the eigenvalue $T = 1$ does not necessarily mean the

ballistic transmission (a well-known example is the perfect transmission in case of resonant tunneling).

For disorder due to rough edges the situation differs fundamentally. In this case the eigenvalues T still follow the bimodal distribution $1/\sqrt{(1-T)T^2}$; however, this has nothing in common with the ballistic-like persistent current we found. The ballistic-like current is due to the appearance of the diagonal element $T_{n=1} \simeq 1$. Specifically, any wire in the statistical ensemble of wires with rough edges exhibits the diagonal element $T_{n=1} \simeq 1$ independently on the choice of the Fermi energy and wire length. It is easy to check for any of our simulated wires, whereby the electron plane wave which enters the wire in channel $n = 1$ remains (almost) unscattered between any two successive scatterers inside the disordered region. As a result, the ring made of such a wire supports the persistent current dominated by the ballistic channel $n = 1$, that is, $I_{\text{typ}} \simeq ev_F/L$. In summary, the reason for the appearance of $I_{\text{typ}} \simeq ev_F/L$ is the ballistic behavior of the diagonal element $T_{n=1}$; the fact that the bimodal distribution shows eigenvalues $T = 1$ is irrelevant.

ACKNOWLEDGMENTS

We thank the Texas Advanced Computing Center (TACC) at the University of Texas at Austin for providing grid resources. Support from Grant No. VEGA 2/0206/11 is acknowledged.

*martin.mosko@savba.sk

¹Y. Imry, *Introduction to Mesoscopic Physics* (Oxford University Press, Oxford, 2002).

²B. S. Deaver, Jr. and W. M. Fairbank, *Phys. Rev. Lett.* **7**, 43 (1961).

³M. Büttiker, Y. Imry, and R. Landauer, *Phys. Lett. A* **96**, 365 (1983).

⁴L. P. Lévy, G. Dolan, J. Dunsmuir, and H. Bouchiat, *Phys. Rev. Lett.* **64**, 2074 (1990).

⁵V. Chandrasekhar, R. A. Webb, M. J. Brady, M. B. Ketchen, W. J. Gallagher, and A. Kleinsasser, *Phys. Rev. Lett.* **67**, 3578 (1991).

⁶E. M. Q. Jariwala, P. Mohanty, M. B. Ketchen, and R. A. Webb, *Phys. Rev. Lett.* **86**, 1594 (2001).

⁷H. Bluhm, N. C. Koshnick, J. A. Bert, M. E. Huber, and K. A. Moler, *Phys. Rev. Lett.* **102**, 136802 (2009).

⁸A. C. Bleszynski-Jayich, W. E. Shanks, B. Peaudecerf, E. Ginossar, F. von Oppen, L. Glazman, and J. G. E. Harris, *Science* **326**, 272 (2009).

⁹D. Mailly, C. Chapelier, and A. Benoit, *Phys. Rev. Lett.* **70**, 2020 (1993).

¹⁰A. Mořková, M. Mořko, and J. Tóvik, *Phys. Status Solidi B* **250**, 147 (2013).

¹¹H. F. Cheung, Y. Gefen, E. K. Riedel, and W. H. Shih, *Phys. Rev. B* **37**, 6050 (1988).

¹²H. F. Cheung, E. K. Riedel, and Y. Gefen, *Phys. Rev. Lett.* **62**, 587 (1989).

¹³E. K. Riedel and F. von Oppen, *Phys. Rev. B* **47**, 15449 (1993).

¹⁴J. Feilhauer and M. Mořko, *Phys. Rev. B* **83**, 245328 (2011).

¹⁵W. E. Shanks, Ph.D. thesis, Yale University, 2011.

¹⁶L. Saminadayar, C. Bäuerle, and D. Mailly, in *Encyclopedia of Nanoscience and Nanotechnology*, edited by H. S. Nalwa

(American Scientific, Valencia, CA, 2004), Vol. 3, pp. 267–285.

¹⁷J. Feilhauer and M. Mořko, *Phys. Rev. B* **84**, 085454 (2011).

¹⁸H. Bary-Soroker, O. Entin-Wohlman, and Y. Imry, *Phys. Rev. Lett.* **101**, 057001 (2008).

¹⁹H. Tamura and T. Ando, *Phys. Rev. B* **44**, 1792 (1991).

²⁰M. Cahay, M. McLennan, and S. Datta, *Phys. Rev. B* **37**, 10125 (1988).

²¹J. A. Torres and J. J. Sáenz, *J. Phys. Soc. Jpn.* **73**, 2182 (2004).

²²A. Bietsch and B. Michel, *Appl. Phys. Lett.* **80**, 3346 (2002).

²³S. Datta, *Electronic Transport in Mesoscopic Systems* (Cambridge University Press, Cambridge, UK, 1995).

²⁴M. C. W. van Rossum and T. M. Nieuwenhuizen, *Rev. Mod. Phys.* **71**, 313 (1999).

²⁵A. García-Martín and J. J. Sáenz, *Wave Random Complex* **15**, 229 (2005).

²⁶P. Markoš, *Acta Physica Slovaca* **56**, 561 (2006).

²⁷P. Vagner, P. Markoš, M. Mořko, and T. Schapers, *Phys. Rev. B* **67**, 165316 (2003).

²⁸J. A. Sánchez-Gil, V. Freilikher, A. A. Maradudin, and I. V. Yurkevich, *Phys. Rev. B* **59**, 5915 (1999).

²⁹R. A. Jalabert, K. Richter, and D. Ullmo, *Surf. Sci.* **372**, 700 (1996).

³⁰K. V. Samokhin, *Phys. Rev. B* **60**, 1511 (1999).

³¹E. Šimánek, *Phys. Lett. A* **250**, 425 (1998), estimated in a linear approximation the Hartree field in the one-channel ring.

³²H. F. Cheung, Y. Gefen, and E. K. Riedel, *IBM J. Res. Dev.* **32**, 359 (1988).

³³G. Kirczenow, *J. Phys.: Condens. Matter* **7**, 2021 (1995).

- ³⁴R. A. Webb, S. Washburn, C. P. Umbach, and R. B. Laibowitz, *J. Magn. Magn. Mater.* **54**, 1423 (1986).
- ³⁵R. L. Graham, G. B. Alers, T. Mountsier, N. Shamma, S. Dhuey, S. Cabrini, R. H. Geiss, D. T. Read, and S. Peddeti, *Appl. Phys. Lett.* **96**, 042116 (2010).
- ³⁶M. Austin and S. Y. Chou, *J. Vac. Sci. Technol.* **20**, 665 (2002).
- ³⁷M. E. Pumarol-Crestar, Ph.D. thesis, McGill University, Montréal (2008).
- ³⁸M. T. Bryan, D. Atkinson, and R. P. Cowburn, *J. Phys.: Conf. Ser.* **17**, 40 (2005).
- ³⁹R. C. Munoz, G. Vidal, G. Kremer, L. Moraga, C. Arenas, and A. Concha, *J. Phys.: Condens. Matter* **12**, 2903 (2000).
- ⁴⁰S. B. Soffer, *J. Appl. Phys.* **38**, 1710 (1967).
- ⁴¹J. M. Ziman, *Electrons and Phonons* (Oxford University Press, London, 1960).